

## SSCU4N20TN4

## **N-Channel Enhancement Mode MOSFET**

#### Features

V <sub>DS</sub>	$V_{GS}$	R <sub>DS(ON)</sub> Typ.	I <sub>D</sub>
20V	+12V	4mΩ@4V5	65A
	<u> </u>	5.5mΩ@2V5	00/1

## Description

The SSCU4N20TN4 uses advanced trench technology to provide excellent RDS(ON) and low gate charge. The complementary MOSFETs may be used to form a level shifted high side switch, and for a host of other applications.

100% UIS + ΔVDS + Rg Tested!

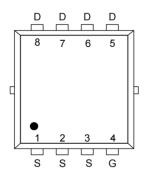
## Applications

- PWM Applications
- Load Switch
- DC-DC Converters
- Wireless Chargers

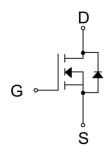
## Ordering Information

Device	Package	Shipping		
SSCU4N20TN4	PDFN3.3X3.3-8L	5000/Reel		

## Pin configuration



PDFN3.3X3.3-8L (Top View)



**Pin Configuration** 



**Marking** 

(XXYY: Internal Traceability Code)



## ➤ Absolute Maximum Ratings (T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Paramete	Ratings	Unit		
V <sub>DSS</sub>	Drain-to-Source	20	V		
V <sub>GSS</sub>	Gate-to-Source	±12	V		
1	Continuous Dunin Coursent d	T <sub>C</sub> =25°C	65	^	
l <sub>D</sub>	Continuous Drain Current d	Tc=100°C	35	A	
1	Continuous Busin Comment 3	T <sub>A</sub> =25°C	23	A	
IDSM	Continuous Drain Current a —	T <sub>A</sub> =70°C	16		
I <sub>DM</sub>	Pulsed Drain C	260	Α		
Ъ	Device Discipation 6	Tc=25°C	28	10/	
$P_D$	Power Dissipation <sup>c</sup>	Tc=100°C	11.2	W	
Ъ	Down Discipation 3	T <sub>A</sub> =25°C	3.3	W	
$P_{DSM}$	Power Dissipation <sup>a</sup>	T <sub>A</sub> =70°C	2.1		
I <sub>AS</sub>	Avalanche Current b L=0.	19	Α		
Eas	Avalanche Energy b L=0.5	90	mJ		
TJ	Operation junction t	-55~150	0.0		
T <sub>STG</sub>	Storage temperat	-55~150	~ ℃		

## > Thermal Resistance Ratings (T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance a	38	°C \\\\\
$R_{ heta JC}$	Junction-to-Case Thermal Resistance	4.5	°C/W

#### Note:

- a. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz.copper,in a still air environment with T<sub>A</sub>=25 °C. The value in any given application depends on the user is specific board design. The current rating is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.

SSC-V1.0 www.sscsemi.com Analog Future



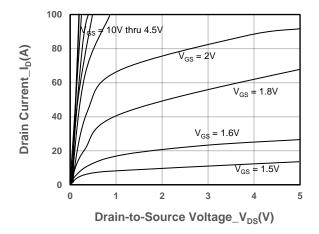
# SSCU4N20TN4

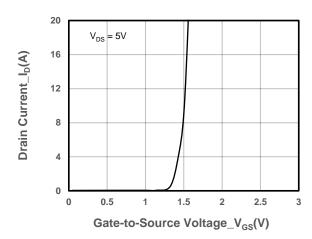
## $\succ$ Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250uA	20			V	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250uA$	0.45	0.7	1.5	V	
Drain-Source On-Resistance	R <sub>DS(on)</sub>	$V_{GS} = 4.5V, I_D = 20A$		4	6	mΩ	
Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 2.5V, I <sub>D</sub> = 15A		5.5	8	mΩ	
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0V			1	uA	
Gate-Source Leak Current	Igss	$V_{GS} = \pm 12V$ , $V_{DS} = 0V$			±100	nA	
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0V, I <sub>S</sub> = 10A			1.3	V	
Gate Resistance	R <sub>G</sub>	V <sub>DS</sub> = 0V, f = 1MHz		1.2		Ω	
Input Capacitance	C <sub>ISS</sub>	V 40V V 0V		3174			
Output Capacitance	Coss	$V_{DS} = 10V$ , $V_{GS} = 0V$ , $f = 1MHz$		398		pF	
Reverse Transfer Capacitance	C <sub>RSS</sub>	T = TIVIDZ		345			
Total Gate Charge	· ·			32			
Gate to Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 4.5V, V <sub>DS</sub> =10V,		7		nC	
Gate to Drain Charge	Q <sub>GD</sub>	I <sub>D</sub> = 15A		10			
Turn-on Delay Time	T <sub>D(ON)</sub>			12			
Rise Time	Tr	V <sub>GS</sub> = 4.5V, V <sub>DS</sub> = 10V,		34			
Turn-off Delay Time	T <sub>D(OFF)</sub>	$I_D = 15A, R_G = 3\Omega$		75		ns	
Fall Time	Tf			91			
Diode Recovery Time	Trr	I <sub>F</sub> =20A, di/dt=100A/us		13.8		ns	
Diode Recovery Charge	Qrr	I <sub>F</sub> =20A, di/dt=100A/us		4		nC	



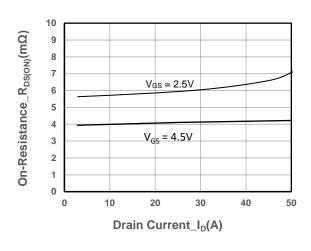
## ➤ Typical Performance Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

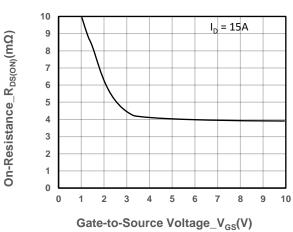




## **Output Characteristics**

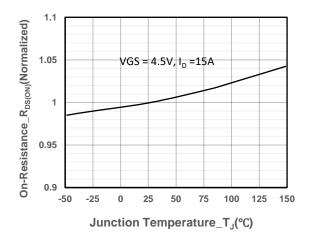


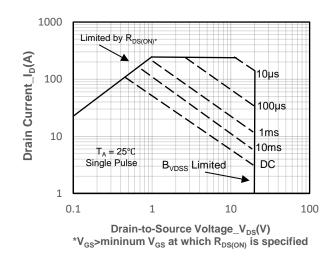




### On-Resistance vs. Drain Current and Gate Voltag

On-Resistance vs. Gate-to-Source Voltage



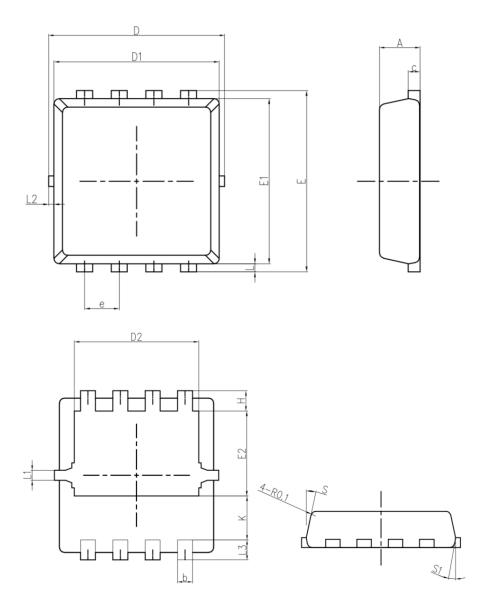


**On-Resistance vs. Junction Temperature** 

Safe Operating Area vs. Junction-to-Ambient



## Package Information



COMMON DIMENSIONS (UNIT of MEASURE=MILLIMETER)											
SYMBOL	MIN	NOM	MAX	SYMBOL	MIN	NOM	MAX	SYMBOL	MIN	NOM	MAX
Α	0.66	0.76	0.86	е	0.55	0.65	0.75	L	0.06	0.15	0.20
b	0.25	0.30	0.35	E	3.15	3.30	3.45	L1	0.10	0.20	0.30
С	0.19	0.20	0.22	E1	3.00	3.10	3.20	L2	0	0.10	0.15
D	3.15	3.30	3.45	E2	1.60	1.70	1.80	L3	0.30	0.40	0.50
D1	3.00	3.10	3.20	Н	0.31	0.41	0.51	S	10°	12°	14°
D2	2.40	2.50	2.60	K	0.79	0.89	0.99	S1	8°	10°	12°



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